





#### **Description**

Current Limiting Module (CLM) is a chip type surface mountable device that can protect against both overcurrent and overcharging. It comprises a fuse element to ensure stable operation under normal electrical current and to cut off the current when overcurrent occurs. It also comprises a resistive heating element that could be used in combination with a voltage detecting means, such as IC and FET. When overvoltage is detected, the heating element is electrically excited to generate heat to blow the fuse element to achieve overvoltage protection.

#### **Features**

- · Halogen-free
- Overcharging protection
- Overcurrent protection

### **Application**

- · Self Balancing
- E-Bike
- Power Tool

Automotive applications

· Surface mountable

· Fast response time

- Energy Storage systems
- Drone

## **Agency Approval and Environmental Compliance**

Agency	File Number	Regulation	Standard
c <b>FL</b> °us	E331807	Halogen Free	IEC 61249-2-21:2003
TÜVRheinand CERTIRED  Regular Production Surveillance WWW.INV.0011 ID M10008807	TA 50428400		

RoHS Directive: Compliance (This product complies with RoHS exemption requirements, since the high melting temperature solder and electronic ceramic parts include Lead.)

#### **Electrical Specifications**

Doub Namahau	Irated	Cells in	V <sub>max</sub> I <sub>break</sub>		Vop	Resistance		Agency Approval	
Part Number	(A)	series	(V <sub>DC</sub> )	(A)	(V)	R <sub>heater</sub> (Ω)	$R_{fuse}$ $(m\Omega)$	<b>c71</b> 2.us	TÜVRheinland
CLM3820P0630H	30	1~2	80	80	4.0 ~ 9.6	0.9 ~ 1.2	0.5 ~ 2.5	✓	✓
CLM3820P1230H	30	3	80	80	8.4 ~ 19.1	3.6 ~ 5.2	0.5 ~ 2.5	✓	✓
CLM3820P1830H	30	4~5	80	80	10.5 ~ 23.5	5.5 ~ 8.0	0.5 ~ 2.5	✓	✓
CLM3820P3030H	30	6~9	80	80	20.2 ~ 46.3	21.0 ~ 31.2	0.5 ~ 2.5	✓	✓
CLM3820P4030H	30	10~14	80	80	28.0 ~ 62.0	40.0 ~ 60.0	0.5 ~ 2.5	✓	✓
CLM3820P5030H	30	15~17	80	80	39.6 ~ 72.0	72.4 ~ 120.6	0.5 ~ 2.5	✓	✓



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#### **Electrical Characteristics**

Current Capacity	100% x I <sub>rated</sub> No Melting
Cut Time	200% x I <sub>rated</sub> < 1 min
Interrupting Current	100A, power on 5 ms, power off 995 ms, 10000 cycles No Melting
Over Voltage Operation	In operation voltage range, the fusing time is <1min.

### **Note on Electrical Specifications & Characteristics**

#### ■ Vocabulary

 $I_{rated}$  = Current carrying capacity that is measured at 40°C thermal equilibrium condition.

 $I_{break}$  = The current that the fuse element is able to interrupt.  $V_{max}$  = The maximum voltage that can be cut off by fuse.

 $V_{op}$  = Range of operation voltage.

 $R_{\text{heater}}$  = The resistance of the heating element.  $R_{\text{fuse}}$  = The resistance of the fuse element.

Cells in series = Number of battery cells connected in series in the circuit for CLM device to protect.

- Value specified is determined by using the PWB with 6mm\*2oz copper traces, AWG10 covered wire, and 0.6mm glass epoxy PCB.
- Specifications are subject to change without notice.

## **AWARNING**

#### General

- Before and after mounted, the ultrasonic-cleaning or immersion-cleaning must not be done to CLM device. The flux on element would flow, and it would not be satisfied its specification when cleaning is done. In addition, a similar influence happens when the product comes in contact with cleaning-solution. These products after cleaning will not be guaranteed.
- Silicone-based oils, oils, solvents, gels, electrolytes, fuels, acids, and the like will adversely affect the properties of CLM devices, and shall not be used or applied.
- Please Do Not reuse the CLM device removed by the soldering process.
- CLM devices are secondary protection devices and are used solely for sporadic, accidental over-current or over-temperature error condition, and shall NOT be used if or when constant or repeated fault conditions (such fault conditions may be caused by, among others, incorrect pin-connection of a connector) or over-extensive trip events may occur.
- Operation over the maximum rating or other forms of improper use may cause failure, arcing, flame and/or other damage to the CLM devices.
- The performance of CLM devices will be adversely affected if they are improperly used under electronic, thermal and/or mechanical procedures and/or conditions non-conformant to those recommended by manufacturer.
- Customers shall be responsible for determining whether it is necessary to have back-up, failsafe and/or fool-proof protection to avoid or minimize damage that may result from extra-ordinary, irregular function or failure of CLM devices.
- There should be minimum of 0.1mm spacing between CLM and surrounding compounds, to maintain the product characteristics and avoid damage other surrounding compounds.
- This product is designed and manufactured only for general-use of electronics devices. We do not recommend that it is used for the applications Military, Medical and so on which may cause direct damages on life, bodies or properties.
- Please prevent to contact resin-mold with CLM devices, which might be infiltrated by resin material and lead to the specification incompatible. It will not be guaranteed after resin-mold has been done to product.



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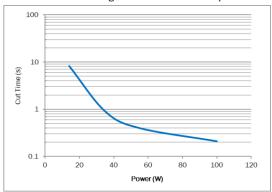


### **Thermal Derating Characteristics**

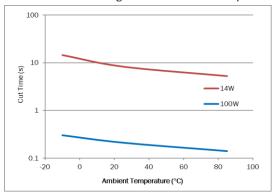
Ambient Temperature (°C)	25	40	60
Recommend Rated Current (A)	34.0	30.0	25.0

### **Cut Time by Heater Operation**

■ Various heater wattage at 25°C ambient temperature.

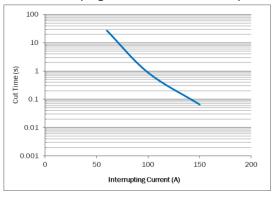


■ Constant heater wattage at various ambient temperature.

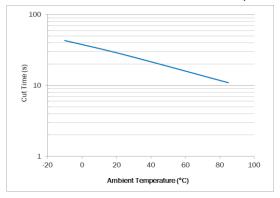


### **Cut Time by Current Operation**

■ Various interrupting current at 25°C ambient temperature.



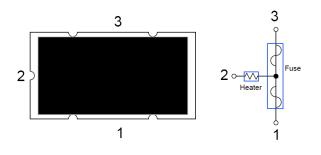
■ Constant 2x rated current at various ambient temperature.



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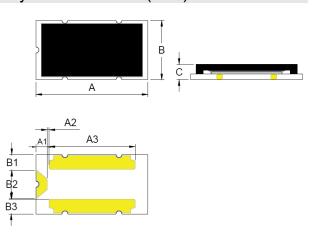
### **Device Circuit**



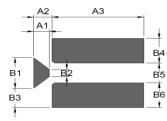
## **Environmental Specifications**

Storage Temperature	0~35°C,≦70%RH
	Shelf life: 1 year
Operating Temperature	-10°C to +65 °C
Het Dessive Aging	100±5°C, 250 hours
Hot Passive Aging	No structural damage and functional failure
Harmadalita Andrew	60°C±2°C, 90~95%R.H. 250 hours
Humidity Aging	No structural damage and functional failure
Oald Dankin Adiod	-20±3°C, 500 hours
Cold Passive Aging	No structural damage and functional failure

### **Physical Dimensions (mm.)**



Poord and Solder	Lavout Recommend (mm)	
board and Solder	Lavout Recommend (mm)	



Material	Glass Epoxy PCB
Base Thickness	0.6mm
Copper Thickness	0.07mm
Covered Wire	AWG10

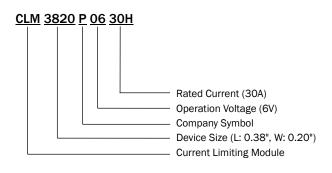
Α	9.50 ± 0.2
В	5.00 ± 0.3
С	2.00 max
A1	$0.89 \pm 0.1$
A2	0.15 ± 0.1
А3	7.32 ± 0.1

B1	$1.32 \pm 0.1$
B2	$2.36 \pm 0.1$
В3	$1.25 \pm 0.1$

A1	$1.30 \pm 0.1$
A2	1.52 ± 0.1
А3	$7.60 \pm 0.1$

B1	$3.10 \pm 0.1$
B2	$0.75 \pm 0.1$
В3	1.95 ± 0.1
B4	$2.50 \pm 0.1$
B5	2.00 ± 0.1
В6	2.50 ± 0.1

### **Part Number System**



### **Part Marking System**

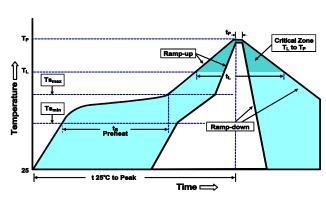




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### **Soldering Parameters**

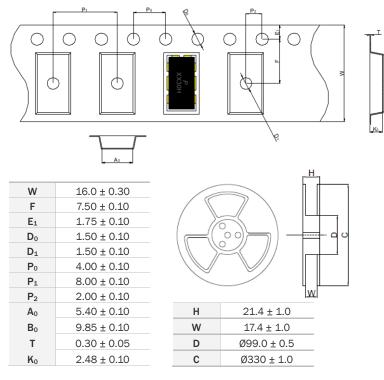


Average Roma IIn Rete (To to T.)	
Average Ramp-Up Rate (Ts <sub>max</sub> to T <sub>P</sub> )	3°C/second max.
Preheat	
-Temperature Min (Ts <sub>min</sub> )	150°C
-Temperature Max (Ts <sub>max</sub> )	200°C
-Time (Ts <sub>min</sub> to Ts <sub>max</sub> )	60-120 seconds
Time maintained above:	
-Temperature (T <sub>L</sub> )	217°C
-Time (t <sub>L</sub> )	60-105 seconds
Peak Temperature (T <sub>P</sub> )	255°C
Time within 5°C of actual Peak	
Temperature (t <sub>P</sub> )	5 seconds max.
Ramp-Down Rate	6°C /second max.
Time 25°C to Peak Temperature	8 minutes max.

Note 1: The temperature shown above is the top-side surface temperature of the device.

Note 2: If the soldering temperature profile deviates from the recommended profile,
devices may not meet the performance requirements

### Tape & Reel Specification (mm.)



### **Packaging Quantity**

Part Number	Tape & Reel Quantity
CLM3820PXX30H	1000



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